

**FH25P03AC****P-Channel Enhancement Mode MOSFET****Description**

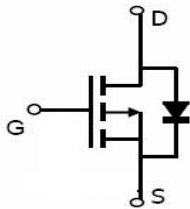
The FH25P03AC is the P-Channel enhancement mode MOSFET in a plastic package (SO-8) using the Trench technology.

Applications

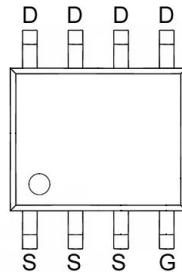
- High Speed Switch
- DC-DC Converters
- Lithium-Ion Battery

Features

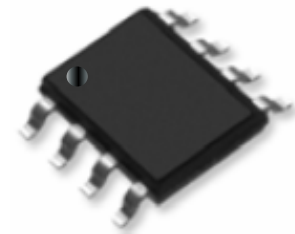
- $V_{DS} = -30V$; $I_D = -7.1A$
 $R_{DS(ON)} < 40m\Omega @ V_{GS} = -10V$
 $R_{DS(ON)} < 55m\Omega @ V_{GS} = -4.5V$
- LogicLevelCompatible
- SMDPackage (SO-8)
- TrenchTechnology
- FastSwitching



Schematic diagram



Marking and Pin Assignment



SO-8 top view

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Typical	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ($T_J = 150^\circ\text{C}$)	I_D	-7.1	A
Pulsed Drain Current (Note 2)	I_{DM}	-28.4	A
Power Dissipation	P_D	2.5	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^\circ\text{C}$
Thermal Resistance-Junction to Ambient (Note 1)	R_{thJA}	48	$^\circ\text{C/W}$

Note: 1. Mounted on FR4 board, $t \leq 10\text{sec}$.

2.Repetitive Rating: Pulse width limited by maximum junction temperature.

■ Electrical Characteristics (T_A = 25°C, unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static						
Drain-source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = -250μA	-30			V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250μA	-1.0	-1.6	-2.5	V
Gate-Body Leakage Current	I _{GSS}	V _{DS} = 0V, V _{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -30V, V _{GS} = 0V			-1	μA
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = -10V, I _D = - 5.5A		30	40	mΩ
		V _{GS} = -4.5V, I _D = - 4.0A		38	55	
Forward Transconductance	g _{FS}	V _{DS} = -5V, I _D = -5.0A	8	13		S
Diode Forward Voltage (Note 2)	V _{SD}	V _{GS} = 0V, I _S = -1.0A			-1.0	V
Diode Forward Current (Note 1)	I _S				-4.0	A
Dynamic (Note 3)						
Total Gate Charge	Q _g	V _{DS} = -15V, V _{GS} = -10V, I _D = -1A		24		nC
Gate-Source Charge	Q _{gs}			3.2		
Gate-Drain Charge	Q _{gd}			2.72		
Input Capacitance	C _{iss}	V _{DS} = -15V, V _{GS} = 0V, f = 1MHz		990		pF
Output Capacitance	C _{oss}			182		
Reverse Transfer Capacitance	C _{rss}			118		
Switching (Note 3)						
Turn-On Delay Time	t _{d(on)}	V _{DD} = -15V, R _L = 15Ω, I _D = -1A, V _{GS} = -4.5V, R _{GEN} = 10Ω		8		nS
Rise Time	t _r			3		
Turn-Off Delay Time	t _{d(off)}			32		
Fall-Time	t _f			10		

- Note:**
1. Mounted on FR4 board, t ≤ 5sec.
 2. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
 3. Guaranteed by design. not subject to production

■ Typical Electrical and Thermal Characteristics

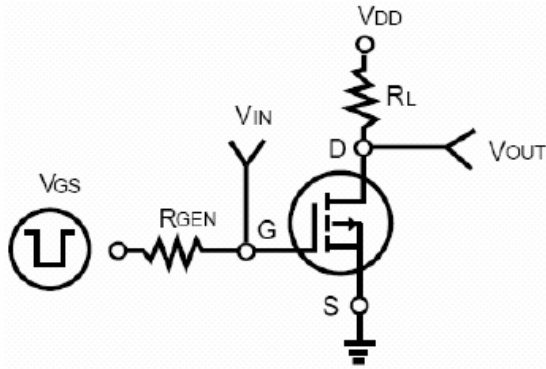


Figure 1: Switching Test Circuit

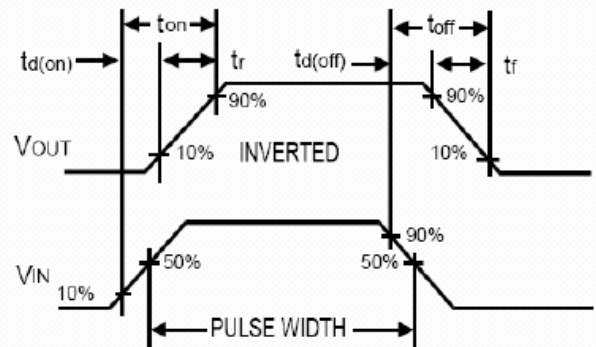
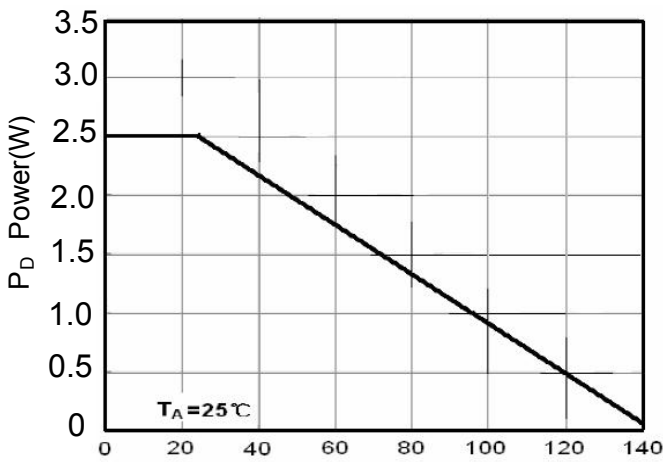
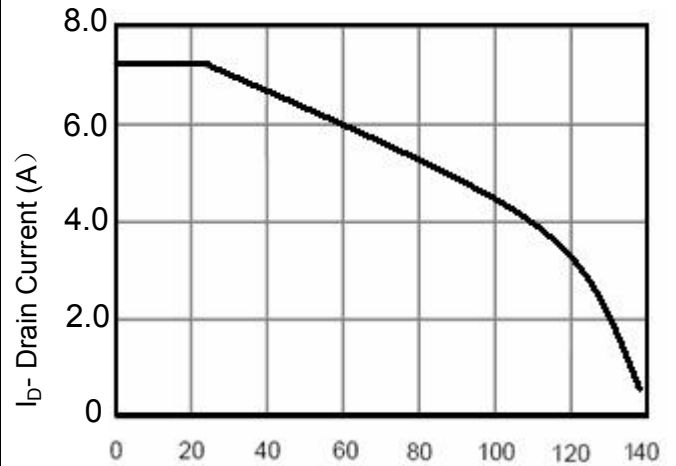


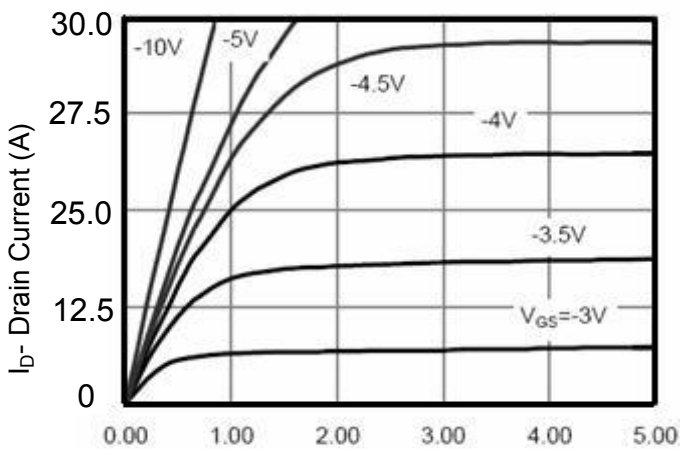
Figure 2: Switching Waveforms



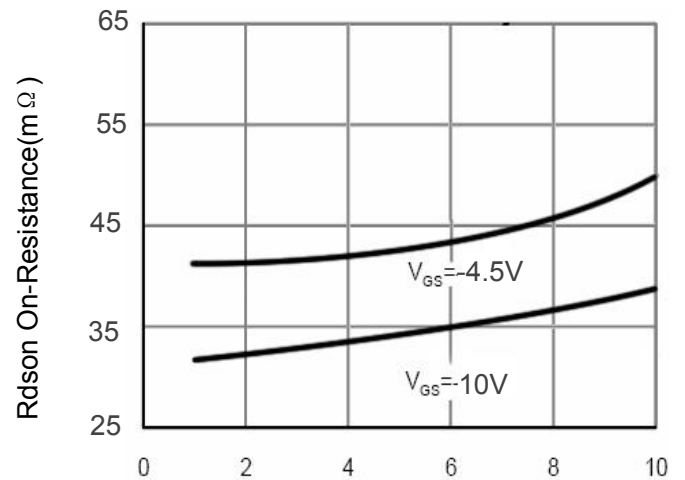
T_J-Junction Temperature(°C)
Figure 3 Power Dissipation



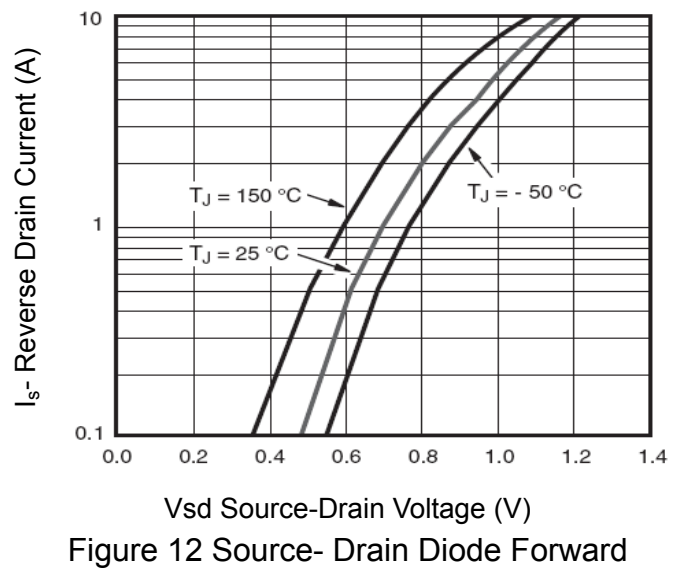
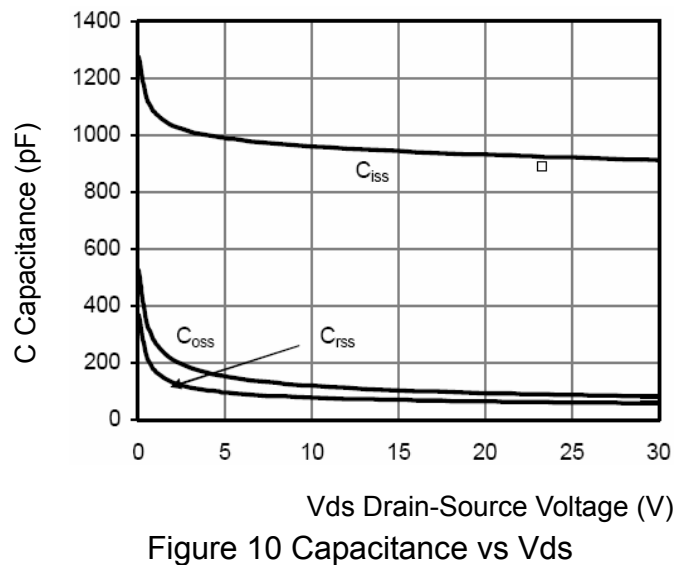
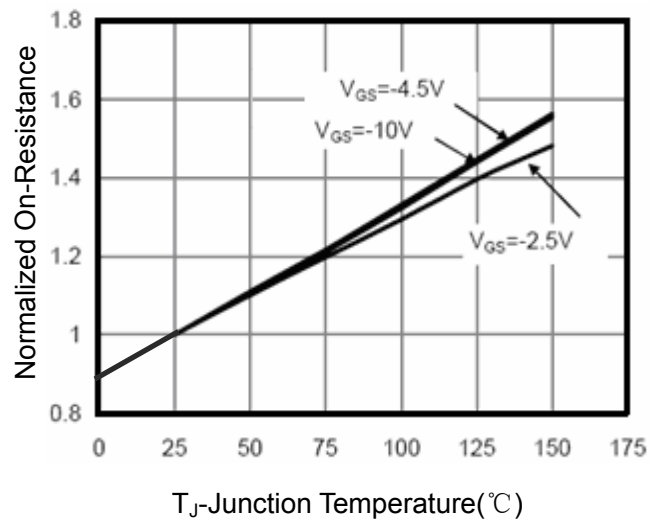
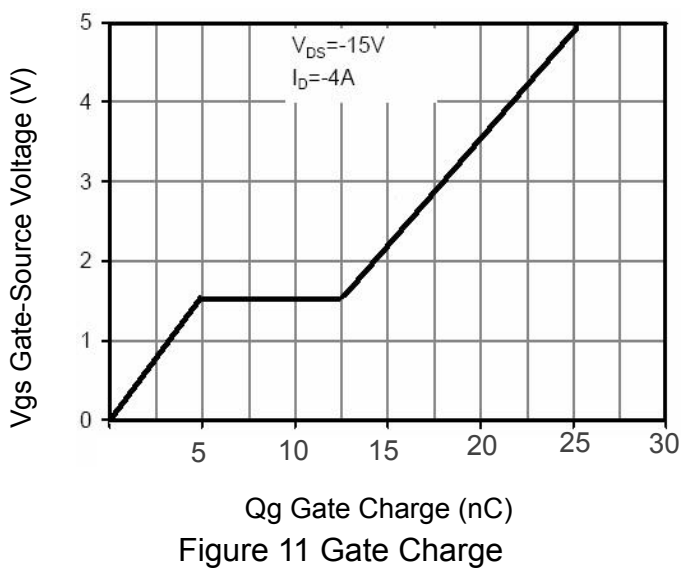
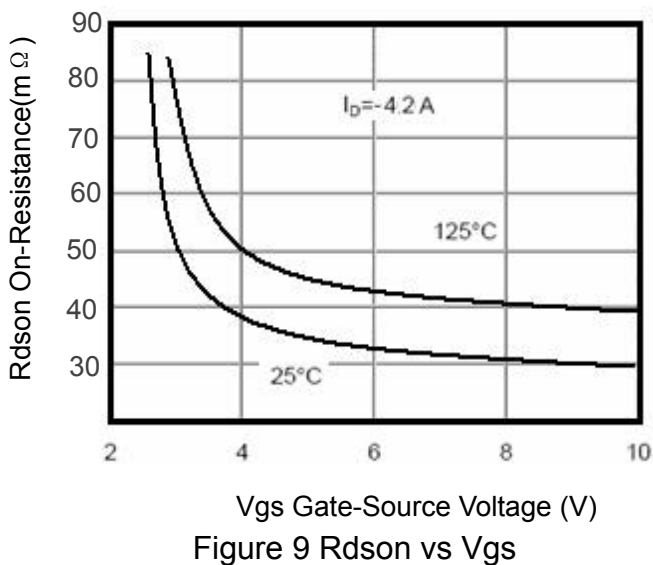
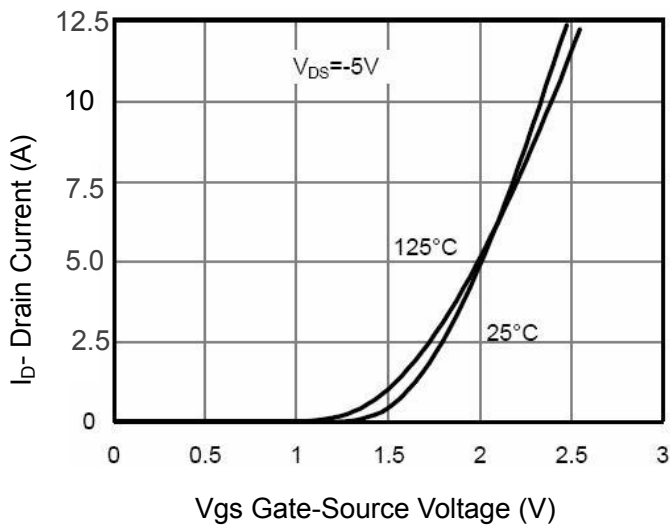
T_J-Junction Temperature(°C)
Figure 4 Drain Current



V_{ds} Drain-Source Voltage (V)
Figure 5 Output Characteristics



I_D- Drain Current (A)
Figure 6 Drain-Source On-Resistance



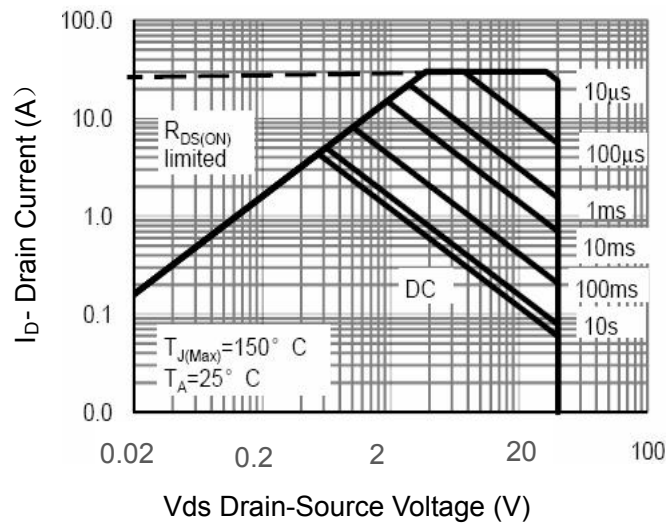


Figure 13 Safe Operation Area

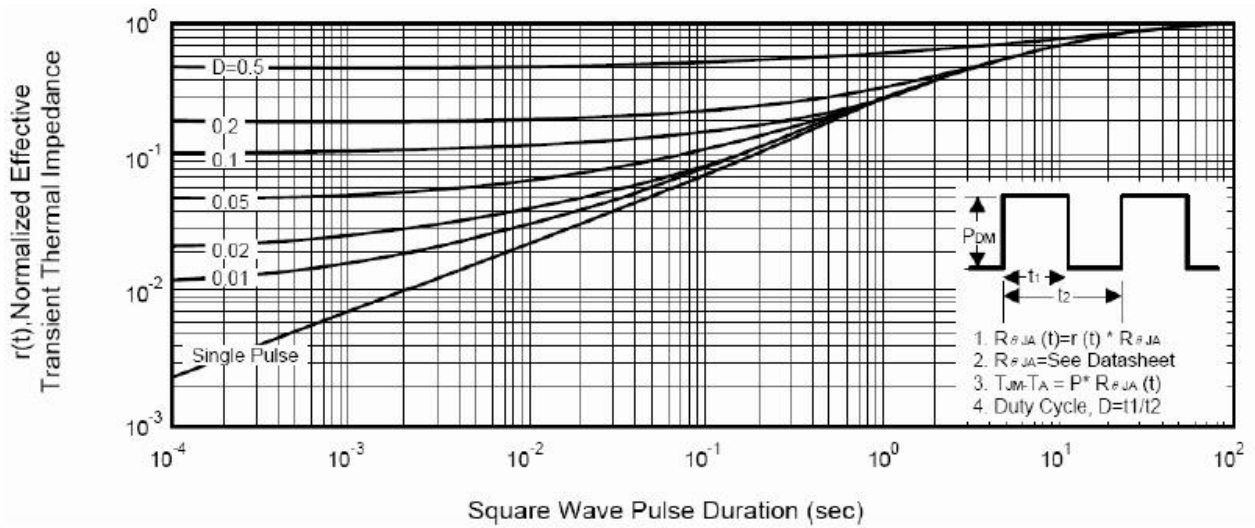
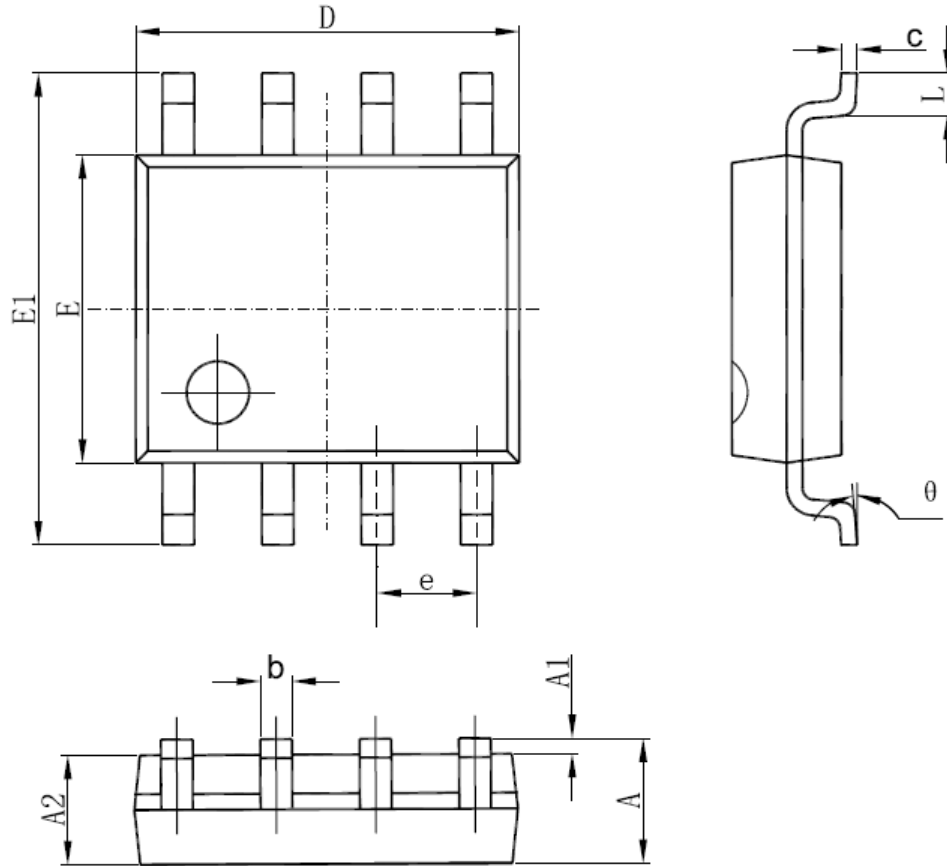


Figure 14 Normalized Maximum Transient Thermal Impedance

■ Package Dimensions : SO-8



SYMBOL	MM		INCH		SYMBOL	MM		INCH	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	1.270 (BSC)		0.050 (BSC)	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0°	8°	0°	8°
D	4.700	5.100	0.185	0.200					